Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/764,057	CHANG ET AL.	
Examiner	· Art Unit	
Brian S. Kwon	1614	

SEARCHED			
Class	Subclass	Date	Examiner
Updated	see search notes	11/19/2007	вк
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		.,	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated (STN, EAST, NPL)	11/19/2007	вк
Updated (Continuity data, inventor name search)		0